

Search Notes	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10540311	AUGUSTUS ET AL.
Examiner	Art Unit	
Young J Kim	1637	

SEARCHED

Class	Subclass	Date	Examiner

SEARCH NOTES

Search Notes	Date	Examiner
re-reviewed the STIC-assisted search of SEQ ID Numbers 1 and 7	5/29/2009	/YJK/
STIC- search reviewed	1/8/2010	/YJK/
Patent Databases (USPT, USPPGP, EPO, JPO, DERWENT, IBM-TDB) - see enclosed for text-search strategy	1/8/2010	/YJK/
updated	8/2/2010	/YJK/

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner
	Interference search history - see enclosed	1/8/2010	/YJK/

	/Young J Kim/ Primary Examiner, Art Unit 1637
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